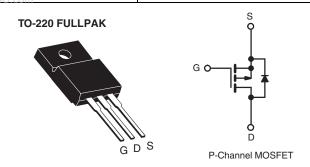


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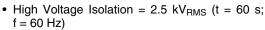
Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 200			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = - 10 V	1.5		
Q _g (Max.) (nC)	15			
Q _{gs} (nC)	3.2			
Q _{gd} (nC)	8.4			
Configuration	Single			



FEATURES

· Isolated Package





COMPLIANT

- Sink to Lead Creepage Dist. = 4.8 mm
- P-Channel
- Dynamic dV/dt
- · Low Thermal Resistance
- · Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION			
Package	TO-220 FULLPAK		
Lead (Pb)-free	IRFI9620GPbF		
	SiHFI9620G-E3		
SnPb	IRFI9620G		
	SiHFl9620G		

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	- 200	V	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V -+ 40.V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	- I _D	- 3.0		
	VGS at - 10 V	T _C = 100 °C		- 1.9	Α	
Pulsed Drain Current ^a			I _{DM}	- 12		
Linear Derating Factor				0.24	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	80	mJ	
Repetitive Avalanche Current ^a			I _{AR}	- 3.0	Α	
Repetitive Avalanche Energy ^a			E _{AR}	3.0	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	30	W	
Peak Diode Recovery dV/dtc			dV/dt	- 5.0	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	7	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 13 mH, R_G = 25 Ω , I_{AS} = 3.0 A (see fig. 12). c. I_{SD} ≤ 3.9 A, I_{CS} = 3.9 A, I_{CS} = 3.0 A (see fig. 12).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFI9620G, SiHFI9620G

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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	4.1	C/VV		

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static						•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	- 200	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = -1 mA			-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	- 2.0	-	- 4.0	٧	
Gate-Source Leakage	I _{GSS}	,	-	-	± 100	nA	
Zawa Cata Waltana Dunin Cumunt	1	V _{DS} = - 200 V, V _{GS} = 0 V		-	100	4	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 160 \	V, V _{GS} = 0 V, T _J = 125 °C	-	-	- 500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 1.8 A ^b	-	-	1.5	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	- 50 V, I _D = - 1.8 A ^b	1.3	-	-	S
Dynamic						•	
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	340	-	
Output Capacitance	C _{oss}		V _{DS} = - 15 V,		110	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	33	-	
Drain to Sink Capacitance	С		f = 1 MHz	-	12	-	
Total Gate Charge	Qg		I _D = - 2.1 A, V _{DS} = - 160 V, see fig. 6 and 13 ^b	-	-	15	nC
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V		-	-	3.2	
Gate-Drain Charge	Q _{gd}			-	-	8.4	
Turn-On Delay Time	t _{d(on)}				8.8	-	- ns
Rise Time	t _r	V_{DD} = - 100 V, I_{D} = - 3.9 A, R_{G} = 18 Ω , R_{D} = 24 Ω , see fig. 10 ^b		-	27	-	
Turn-Off Delay Time	t _{d(off)}			-	7.3	-	
Fall Time	t _f			-	19	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s					•	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 3.0	А
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 12	^
Body Diode Voltage	V_{SD}	$T_{J} = 25 ^{\circ}\text{C}, I_{S} = -3.0 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	- 6.3	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = - 3.9 A, dl/dt = 100 A/μs ^b		-	150	300	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.97	2.0	μС
Forward Turn-On Time	t _{on}	Intrinsic tu	on is don	ninated by	y L _S and I	_D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

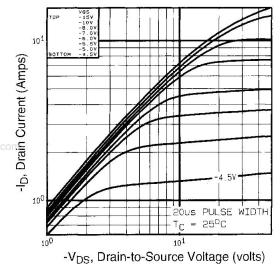


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

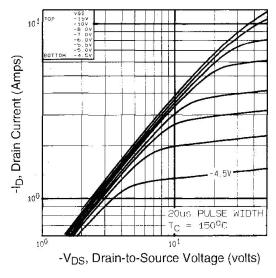


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

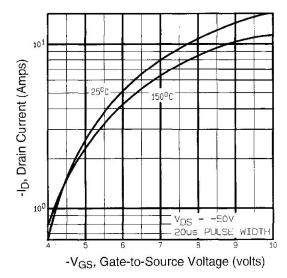


Fig. 3 - Typical Transfer Characteristics

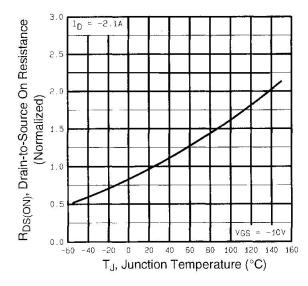


Fig. 4 - Normalized On-Resistance vs. Temperature

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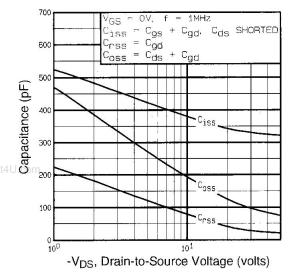


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

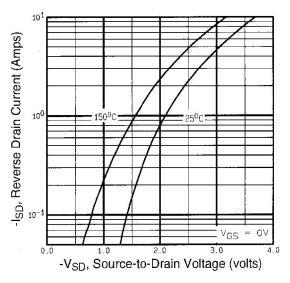


Fig. 7 - Typical Source-Drain Diode Forward Voltage

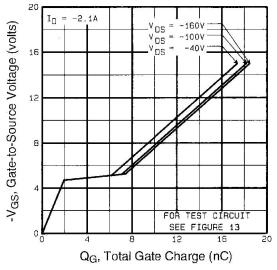


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

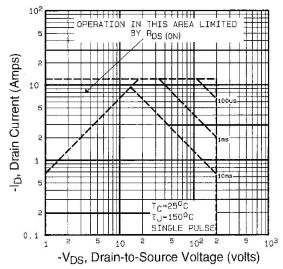


Fig. 8 - Maximum Safe Operating Area



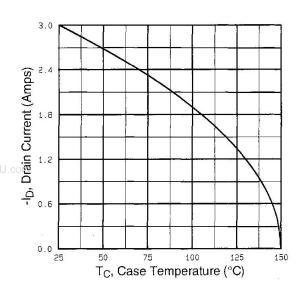


Fig. 9 - Maximum Drain Current vs. Case Temperature

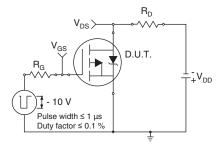


Fig. 10a - Switching Time Test Circuit

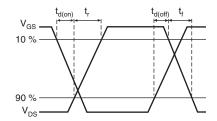


Fig. 10b - Switching Time Waveforms

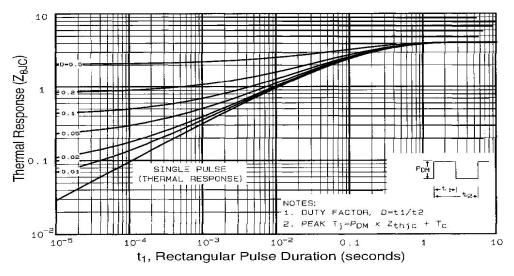


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

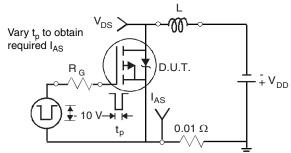


Fig. 12a - Unclamped Inductive Test Circuit

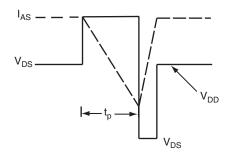


Fig. 12b - Unclamped Inductive Waveforms

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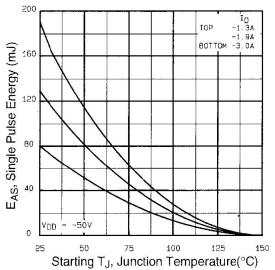


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

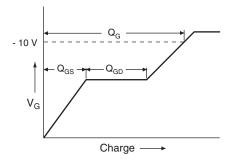


Fig. 13a - Basic Gate Charge Waveform

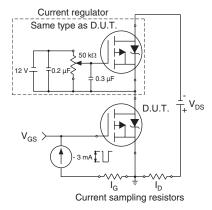
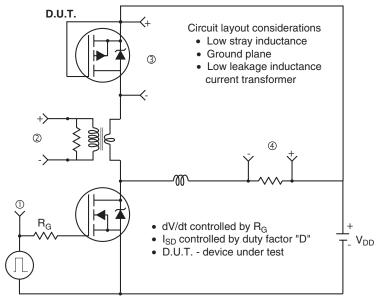


Fig. 13b - Gate Charge Test Circuit

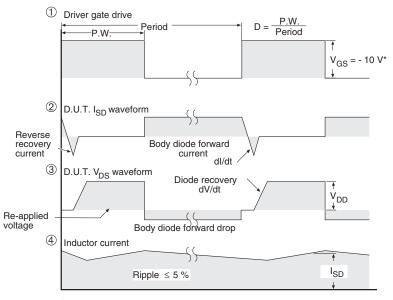




Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver



* $V_{GS} = -5$ V for logic level and -3 V drive devices Fig. 14 - For P-Channel

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